

Notice of References Cited	Application/Control No. 10/664,714	Applicant(s)/Patent Under Reexamination BEDELL ET AL.	
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	B	US-6,689,671	02-2004	Yu et al.	438/486
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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